Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/108,189	TANNER ET AL.	
Examiner	Art Unit	
Mark K. Han	3767	

SEARCHED				
Class	Subclass	Date	Examiner	
604 	93.01 96.01	8/21/2006	inel	
	158 164.01			
	164.02			
	164.07			
	167.01			
	167.02			
	167.06			
	171 256			
	261 500			
	506 507			
	508 509			
V	510 513			
606	192			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search	8/21/2006 (meh